

RoHS Compliant Product
A suffix of "-C" specifies halogen free

DESCRIPTION

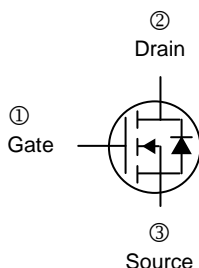
SSA55H12J uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. This device is suitable for the use in a wide variety of applications.

FEATURES

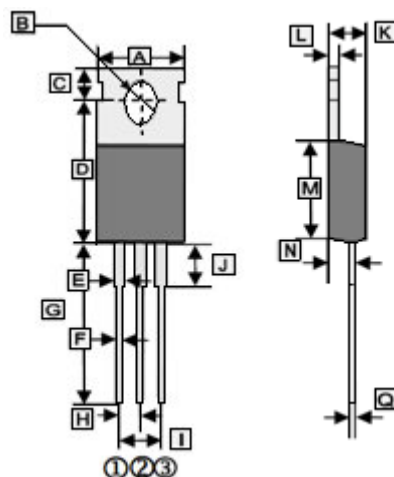
- High density cell design for ultra low $R_{DS(on)}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special processing technology for high ESD capability

APPLICATION

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



TO-220J-A



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	9.91	10.25	I	4.98	5.18
B	3.4	3.8	J	2.85	3.25
C	2.65	2.95	K	4.4	4.6
D	12.65	12.95	L	1.2	1.4
E	1.17	1.37	M	8.95	9.75
F	0.71	0.91	N	2.25	2.55
G	12.9	13.4	Q	0.33	0.65
H	2.540 TYP.				

ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V _{DS}	55	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current	I _D	120	A
Pulsed Drain Current	I _{DM}	420	A
Single Pulsed Avalanche Energy ¹	E _{AS}	1100	mJ
Thermal Resistance from Junction to Ambient	R _{θJA}	62.5	°C/W
Maximum Lead Temperature for Soldering Purposes@ 1/8" from Case for 5 seconds	T _L	260	°C
Junction and Storage Temperature Range	T _J , T _{STG}	150, -55~150	°C

ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise specified)

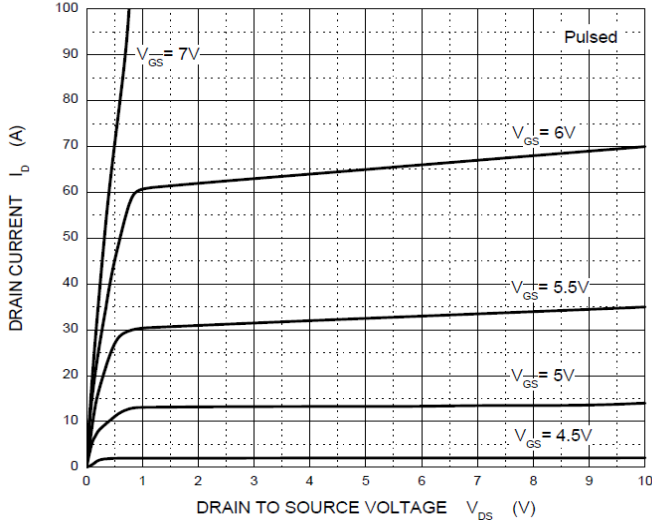
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Off Characteristics						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	55	65	-	V	$V_{GS}=0, I_D=250\mu\text{A}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$V_{DS}=55\text{V}, V_{GS}=0$
		-	-	100		$V_{DS}=0.8 \times \text{Rated } V_{(BR)DSS}, V_{GS}=0, T_J=125^\circ\text{C}$
Gate-Body Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$
On Characteristics ²						
Gate-Threshold Voltage	$V_{GS(th)}$	2	-	4	V	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	-	4.1	5.5	m Ω	$V_{GS}=10\text{V}, I_D=40\text{A}$
Forward Transconductance	g_{FS}	-	50	-	S	$V_{DS}=25\text{V}, I_D=40\text{A}$
Dynamic Characteristics						
Input Capacitance	C_{iss}	-	4900	-	pF	$V_{DS}=25\text{V}$ $V_{GS}=0$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	470	-		
Reverse Transfer Capacitance	C_{rss}	-	460	-		
Switching Characteristics ²						
Total Gate Charge	Q_g	-	125	-	nC	$V_{DS}=30\text{V}$ $V_{GS}=10\text{V}$ $I_D=30\text{A}$
Gate-Source Charge	Q_{gs}	-	24	-		
Gate-Drain Charge	Q_{gd}	-	49	-		
Turn-on Delay Time	$T_{d(on)}$	-	20	-	nS	$V_{DS}=30\text{V}$ $V_{GS}=10\text{V}$ $R_{GEN}=2.5\Omega$ $I_D=2\text{A}$
Rise Time	T_r	-	19	-		
Turn-off Delay Time	$T_{d(off)}$	-	70	-		
Fall Time	T_f	-	30	-		
Source-Drain Diode Characteristics						
Diode Forward Voltage ²	V_{SD}	-	-	1.2	V	$V_{GS}=0, I_S=40\text{A}$
Continuous Drain-Source Diode Forward Current ³	I_S	-	-	120	A	
Pulsed Drain-Source Diode Forward Current	I_{SM}	-	-	420	A	

Notes:

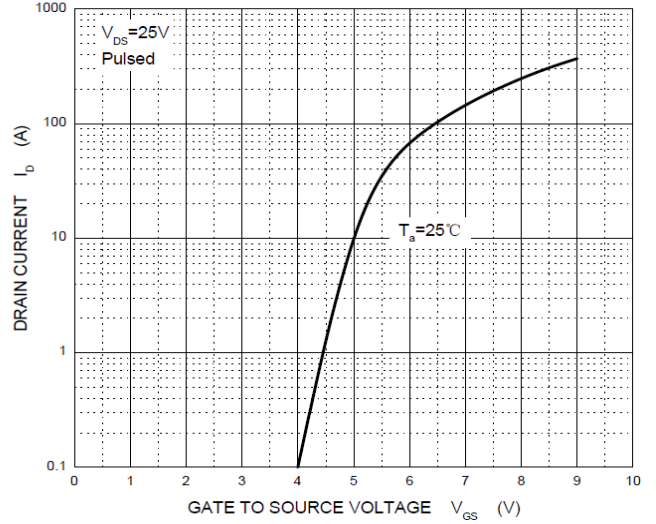
1. E_{AS} condition: $V_{DD}=30\text{V}, L=0.5\text{mH}, R_G=25\Omega$, starting $T_J=25^\circ\text{C}$.
2. Pulse test : Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
3. The surface of the device is mounted on a FR4 board, $t \leq 10\text{s}$.

CHARACTERISTIC CURVES

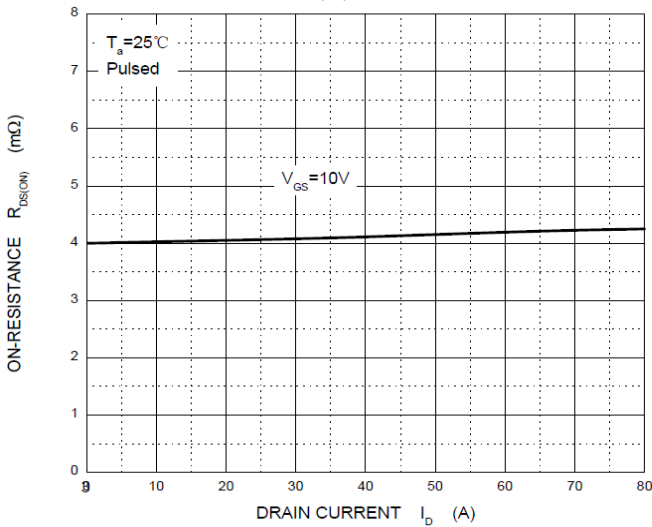
Output Characteristics



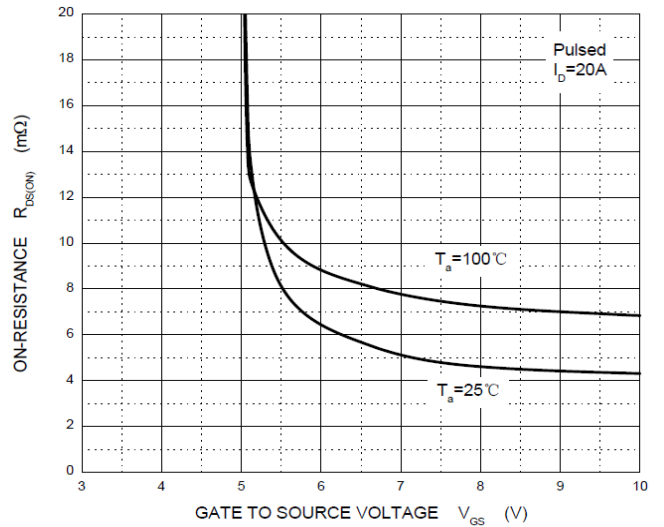
Transfer Characteristics



$R_{DS(ON)}$ — I_D



$R_{DS(ON)}$ — V_{GS}



I_S — V_{SD}

Threshold Voltage

